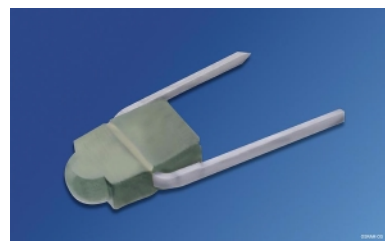


# Mini-NPN-Silizium-Fototransistor Mini-Silicon NPN Phototransistor

## SFH 305



### Wesentliche Merkmale

- Speziell geeignet für Anwendungen im Bereich von 460 nm bis 1060 nm
- Hohe Linearität
- Mini-Bauform
- Gruppiert lieferbar

### Anwendungen

- Miniaturlichtschranken für Gleich- und Wechsellichtbetrieb
- Lochstreifenleser
- Industrieelektronik
- „Messen/Steuern/Regeln“

### Features

- Especially suitable for applications from 460 nm to 1060 nm
- High linearity
- Mini-package
- Available in groups

### Applications

- Miniature photointerrupters
- Punched tape reading
- Industrial electronics
- For control and drive circuits

| Typ<br>Type | Bestellnummer<br>Ordering Code |
|-------------|--------------------------------|
| SFH 305     | Q62702-P836                    |
| SFH 305-2/3 | Q62702-P3589                   |

**Grenzwerte**  
**Maximum Ratings**

| Bezeichnung<br>Parameter                                                                                                                                                                      | Symbol<br>Symbol  | Wert<br>Value | Einheit<br>Unit |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|---------------|-----------------|
| Betriebs- und Lagertemperatur<br>Operating and storage temperature range                                                                                                                      | $T_{op}; T_{stg}$ | - 40 ... + 80 | °C              |
| Löttemperatur bei Tauchlötung<br>Lötstelle $\geq 2$ mm vom Gehäuse, Lötzeit $t \leq 5$ s<br>Dip soldering temperature $\geq 2$ mm distance<br>from case bottom, soldering time $t \leq 5$ s   | $T_s$             | 230           | °C              |
| Löttemperatur bei Kolbenlötung<br>Lötstelle $\geq 2$ mm vom Gehäuse, Lötzeit $t \leq 3$ s<br>Iron soldering temperature $\geq 2$ mm distance<br>from case bottom, soldering time $t \leq 3$ s | $T_s$             | 300           | °C              |
| Kollektor-Emitterspannung<br>Collector-emitter voltage                                                                                                                                        | $V_{CE}$          | 32            | V               |
| Kollektorstrom<br>Collector current                                                                                                                                                           | $I_C$             | 50            | mA              |
| Kollektorspitzenstrom, $\tau < 10 \mu s$<br>Collector surge current                                                                                                                           | $I_{CS}$          | 200           | mA              |
| Verlustleistung, $T_A = 25^\circ C$<br>Power dissipation                                                                                                                                      | $P_{tot}$         | 70            | mW              |
| Wärmewiderstand<br>Thermal resistance                                                                                                                                                         | $R_{thJA}$        | 950           | K/W             |

Kennwerte ( $T_A = 25\text{ °C}$ ,  $\lambda = 950\text{ nm}$ )

## Characteristics

| Bezeichnung<br>Parameter                                                                                                                         | Symbol<br>Symbol             | Wert<br>Value    | Einheit<br>Unit |
|--------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------|------------------|-----------------|
| Wellenlänge der max. Fotoempfindlichkeit<br>Wavelength of max. sensitivity                                                                       | $\lambda_{S\text{ max}}$     | 850              | nm              |
| Spektraler Bereich der Fotoempfindlichkeit<br>$S = 10\%$ von $S_{\text{max}}$<br>Spectral range of sensitivity<br>$S = 10\%$ of $S_{\text{max}}$ | $\lambda$                    | 460 ... 1060     | nm              |
| Bestrahlungsempfindliche Fläche<br>Radiant sensitive area                                                                                        | $A$                          | 0.17             | mm <sup>2</sup> |
| Abmessungen der Chipfläche<br>Dimensions of chip area                                                                                            | $L \times B$<br>$L \times W$ | $0.6 \times 0.6$ | mm × mm         |
| Abstand Chipoberfläche zu Gehäuseoberfläche<br>Distance chip front to case surface                                                               | $H$                          | 1.3 ... 1.9      | mm              |
| Halbwinkel<br>Half angle                                                                                                                         | $\varphi$                    | $\pm 16$         | Grad<br>deg.    |
| Kapazität<br>Capacitance<br>$V_{CE} = 0\text{ V}$ , $f = 1\text{ MHz}$ , $E = 0$                                                                 | $C_{CE}$                     | 5.5              | pF              |
| Dunkelstrom<br>Dark current<br>$V_{CE} = 25\text{ V}$ , $E = 0$                                                                                  | $I_{CEO}$                    | 3 ( $\leq 20$ )  | nA              |

Die Fototransistoren werden nach ihrer Fotoempfindlichkeit gruppiert und mit arabischen Ziffern gekennzeichnet.

The phototransistors are grouped according to their spectral sensitivity and distinguished by arabian figures.

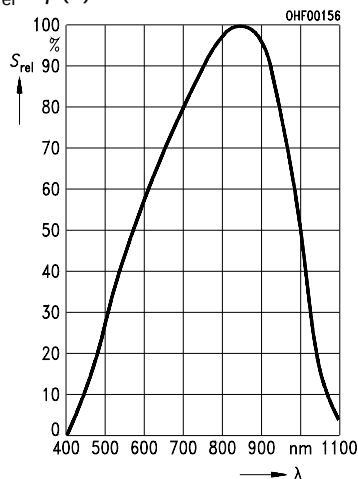
| Bezeichnung<br>Parameter                                                                                                                                                                         | Symbol<br>Symbol       | Wert<br>Value       |                    | Einheit<br>Unit |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------|---------------------|--------------------|-----------------|
|                                                                                                                                                                                                  |                        | -2                  | -3                 |                 |
| Fotostrom, $\lambda = 950 \text{ nm}$<br>Photocurrent<br>$E_e = 0.5 \text{ mW/cm}^2$ , $V_{CE} = 5 \text{ V}$<br>$E_v = 1000 \text{ lx}$ , Normlicht/standard light A,<br>$V_{CE} = 5 \text{ V}$ | $I_{PCE}$<br>$I_{PCE}$ | 0.25 ... 0.5<br>1.4 | 0.4 ... 0.8<br>2.2 | mA<br>mA        |
| Anstiegszeit/Abfallzeit<br>Rise and fall time<br>$I_C = 1 \text{ mA}$ , $V_{CC} = 5 \text{ V}$ , $R_L = 1 \text{ k}\Omega$                                                                       | $t_r$ , $t_f$          | 5.5                 | 6                  | $\mu\text{s}$   |
| Kollektor-Emitter-Sättigungsspannung<br>Collector-emitter saturation voltage<br>$I_C = I_{PCEmin}^{1)} \times 0.3$ ,<br>$E_e = 0.5 \text{ mW/cm}^2$                                              | $V_{CEsat}$            | 150                 | 150                | mV              |

<sup>1)</sup>  $I_{PCEmin}$  ist der minimale Fotostrom der jeweiligen Gruppe.

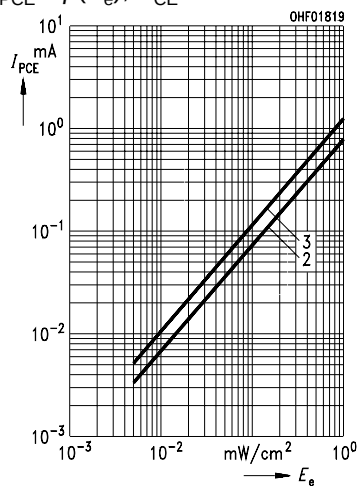
<sup>1)</sup>  $I_{PCEmin}$  is the min. photocurrent of the specified group.

**Relative Spectral Sensitivity**

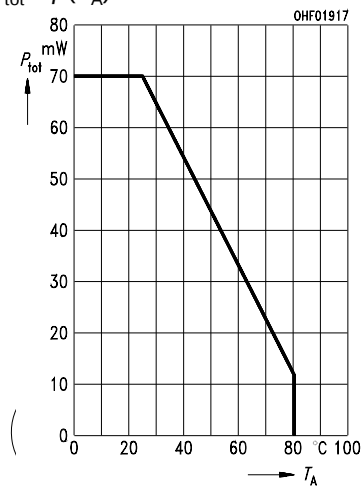
$$S_{\text{rel}} = f(\lambda)$$

**Photocurrent**

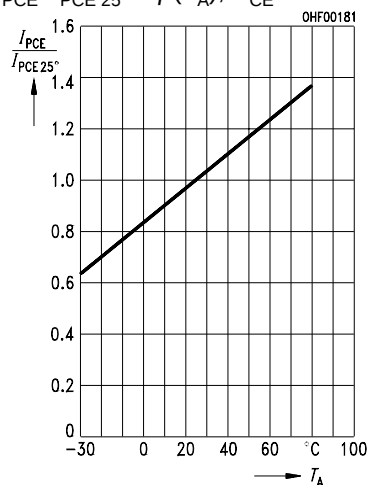
$$I_{\text{PCE}} = f(E_e), V_{\text{CE}} = 5 \text{ V}$$

**Total Power Dissipation**

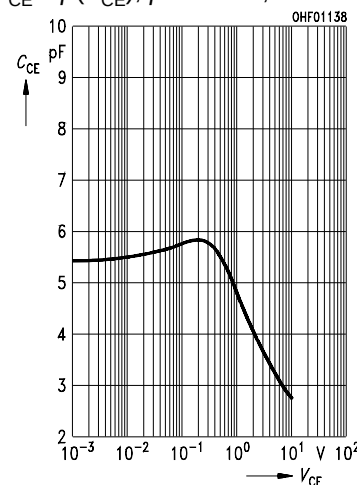
$$P_{\text{tot}} = f(T_A)$$

**Photocurrent**

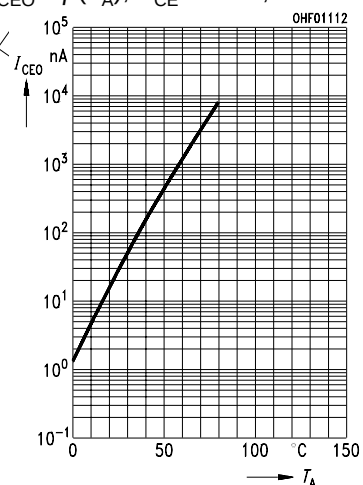
$$I_{\text{PCE}} / I_{\text{PCE } 25^\circ} = f(T_A), V_{\text{CE}} = 5 \text{ V}$$

**Collector-Emitter Capacitance**

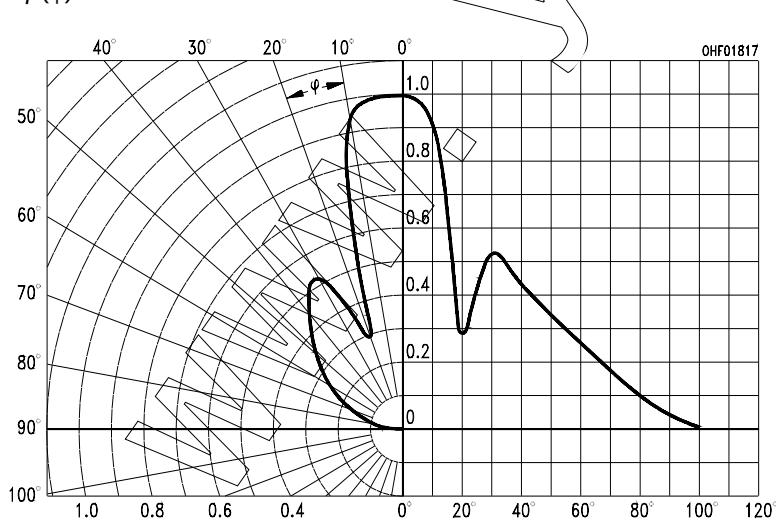
$$C_{\text{CE}} = f(V_{\text{CE}}), f = 1 \text{ MHz}, E = 0$$

**Dark Current**

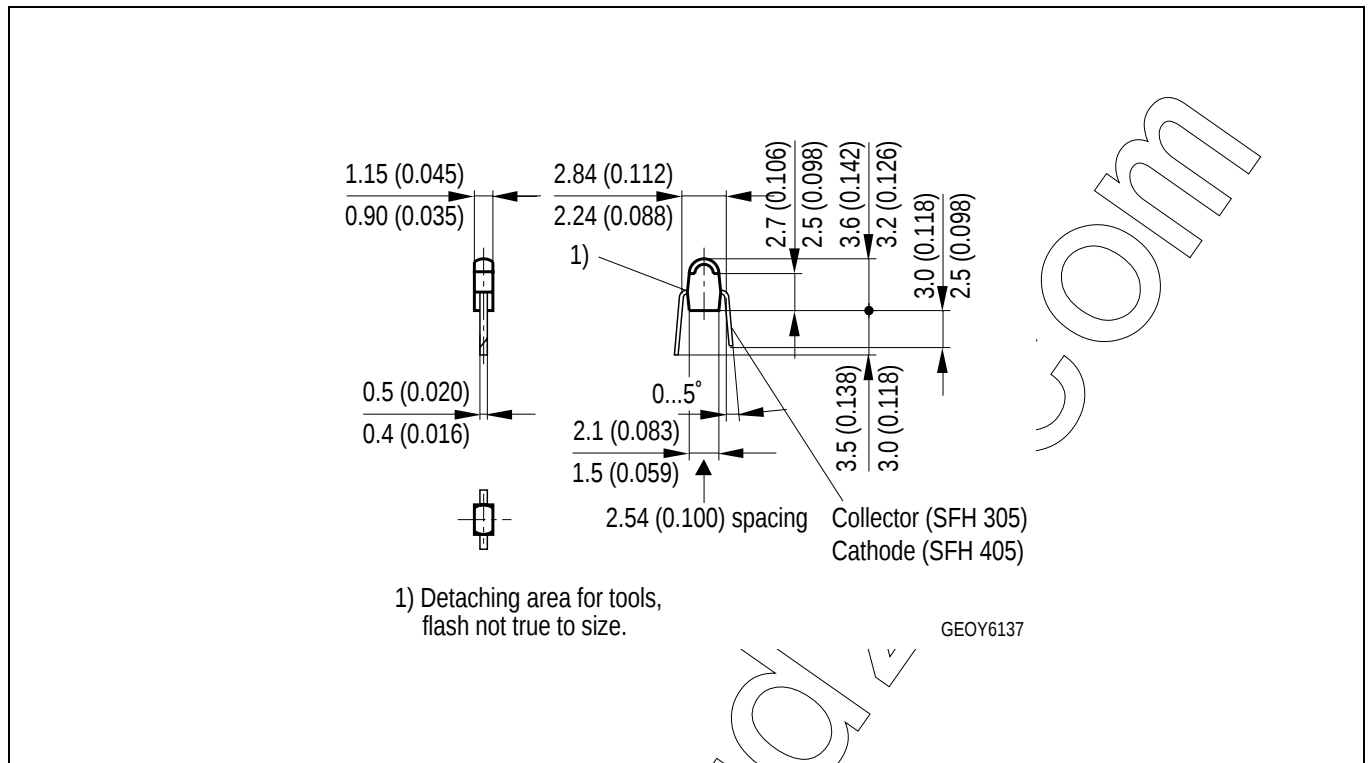
$$I_{\text{CEO}} = f(T_A), V_{\text{CE}} = 25 \text{ V}, E = 0$$

**Directional Characteristics**

$$S_{\text{rel}} = f(\varphi)$$



## Maßzeichnung Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

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### Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

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